

<b>Notice of References Cited</b>	Application/Control No. 09/994,585	Applicant(s)/Patent Under Reexamination LEVINSON, DOUGLAS	
	Examiner Jon D. Epperson	Art Unit 1639	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-			
	C	US-			
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	F	US-			
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	J	US-			
	K	US-			
	L	US-			
	M	US-			

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*	N	WO 01/51919	01-2001	WIPO	Levinson et al.	G01N 30/00
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#### NON-PATENT DOCUMENTS

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*	X	Findlay, W. P.; Bugay, D. E. "Utilization of Fourier transform-Raman spectroscopy for the study of pharmaceutical crystal forms" Journal of Pharmaceutical and Biomedical Analysis 1998, 16, 921-930

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.